





## TEST REPORT IEC 60384-14

Fixed capacitors for use in electronic equipment -

Part 14: Sectional specification - Fixed capacitors for electromagnetic interference suppression and connection to the supply mains

 Report Number......
 263952-TL3-1

 Date of issue......
 2019-11-26

Total number of pages .....: 21

Name of Testing Laboratory VDE Prüf- und Zertifizierungsinstitut GmbH preparing the Report ...........: VDE Testing and Certification Institute

Applicant's name .....: Shenzhen Weidy Industrial Development Co., Ltd.

Address...... 5/F, New Asia Electronic Town; Zhenzhong Rd., Futian; 518031

SHENZHEN; Guangdong CHINA

Test specification:

Standard .....: IEC 60384-14:2013, AMD1:2016

Test procedure .....: CB Scheme

Non-standard test method .....: N/A

Test Report Form No. ...... IEC60384\_14G
Test Report Form(s) Originator ....: SGS Fimko Ltd
Master TRF ...... Dated 2017-06

Copyright © 2017 IEC System of Conformity Assessment Schemes for Electrotechnical Equipment and Components (IECEE System). All rights reserved.

This publication may be reproduced in whole or in part for non-commercial purposes as long as the IECEE is acknowledged as copyright owner and source of the material. IECEE takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context.

If this Test Report Form is used by non-IECEE members, the IECEE/IEC logo and the reference to the CB Scheme procedure shall be removed.

This report is not valid as a CB Test Report unless signed by an approved CB Testing Laboratory and appended to a CB Test Certificate issued by an NCB in accordance with IECEE 02.

## General disclaimer:

The test results presented in this report relate only to the object tested.

This report shall not be reproduced, except in full, without the written approval of the Issuing CB Testing Laboratory. The authenticity of this Test Report and its contents can be verified by contacting the NCB, responsible for this Test Report.

Test item description::		Fixed capacitor for electromagnetic interference suppression and connection to the supply mains			
Trade Mark:		WEIDY			
Ele		Electro	Shenzhen Weidy Industrial Development Co., Ltd.; 5/F, New Asia Electronic Town; Zhenzhong Rd., Futian; 518031 SHENZHEN; Guangdong CHINA		
Model/Type reference: WYS		WYS	YS		
		pF to 470 pF; X1 / Y1; Y1: 250/300/400/500VAC 500VAC; ±10% (K) or ±20% (M); 40/125/21/C; Y5P			
		X1.50	UVAC; ±10% (K) OF ±20%	6 (M); 40/125/21/C, 15P	
Res	ponsible Testing Laboratory (as a	applicat	ole), testing procedure	and testing location(s):	
□ CB Testing Laboratory:		VDE Prüf- und Zertifizierungsinstitut GmbH VDE Testing and Certification Institute			
Testing location/ address:		Merianstrasse 28, 63069 Offenbach, Germany			
Tested by (name, function, signature):			Holger Roß Testing engineer (authorization of test report)	Holge Rys	
Approved by (name, function, signature):		Julian Fritz Technical certification officer	1. TriAz		
П	Testing procedure: CTF Stage 1	41		0	
Testing location/ address:					
Tested by (name, function, signature):					
Approved by (name, function, signature):					
Testing procedure: CTF Stage 2:					
res	ting location/ address				
Tested by (name + signature):					
Witnessed by (name, function, signature) .:		(authorization of test report)			
Approved by (name, function, signature):					
	Testing procedure: CTF Stage 3				
	Testing procedure: CTF Stage 4			$\rightarrow$	
Testing location/ address:		X	<u> </u>		
Tested by (name, function, signature):		171			
Witnessed by (name, function, signature) .:			20		
Approved by (name, function, signature):					
Supervised by (name, function, signature):					
-				I.	

## List of Attachments (including a total number of pages in each attachment):

### Summary of testing:

The tests were performed according to complete schedule for safety requirements given in table 3 of IEC 60384-14:2013 (Fourth Edition), and IEC 60384-14:2013/AMD1:2016.

The testing was performed according to the highest testing severities which are applicable for the capacitor classes X1-500 V and Y1-500 V.

Therefore according to CTL-Decision DSH 1048 the requirements for both capacitor classes  $X1-500\ V$  and  $Y1-500\ V$  are fulfilled.

As the testing for the rated voltage value AC 500 V for capacitor class X1 and for the rated voltage value AC 500 V for capacitor class Y1 is representing the higher testing severity compared to the testing for the additionally requested lower rated voltage values AC 400/300/250 V for capacitor class X1/Y1, no additional testing is required for covering these lower rated voltage values.

As the manufacturer uses different types of case materials and different conducting layer, samples of all used materials were subjected to the testing in order to cover all alternatively used case materials and conducting materials.

The details regarding the used materials for the tested samples are given on page 21.

# Tests performed (name of test and test clause):

- 4.1 Visual examination
- 4.2.1 Voltage proof
- 4.2.2 Capacitance
- 4.2.4 Resistance (if applicable)
- 4.2.5 Insulation resistance
- 4.1.1 Creepage distances and clearances
- 4.3 Robustness of terminations
- 4.4 Resistance of soldering heat
- 4.20 Solvent resistance of the marking
- 4.12 Damp heat, steady state
- 4.13 Impulse voltage
- 4.14 Endurance Class X and Y, RC units, Lead-through (if applicable)
- 4.17 Passive flammability
- 4.18 Active flammability

#### Testing location:

VDE Prüf- und Zertifizierungsinstitut GmbH VDE Testing and Certification Institute Merianstraße 28, 63069 Offenbach, Germany Summary of compliance with National Differences (List of countries addressed):

List of countries addressed:

☑ The product fulfils the requirements of IEC 60384-14:2013 (Fourth Edition)

## Copy of marking plate:

The artwork below may be only a draft. The use of certification marks on a product must be authorized by the respective NCBs that own these marks.



